

## Tuning The Conductance Of Single Walled Carbon Nanotubes By Ion Irradiation In The Anderson Localization Regime.

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Defects are known to modify the electrical resistance of carbon nanotubes. They can be present in as-grown carbon nanotubes, but controlling externally their density opens a path towards the tuning of the nanotube electronic characteristics. In this work consecutive  $\text{Ar}^+$  irradiation doses are applied to single-walled nanotubes (SWNTs) producing a uniform density of defects. After each dose, the room temperature resistance versus SWNT-length dependence ( $R(L)$ ) along the nanotube is measured by using atomic force microscopy (AFM). Our data show an exponential dependence of  $R(L)$  indicating that the system is in strong Anderson localization regime. Simulations demonstrate that mainly di-vacancies contribute to the resistance increase induced by irradiation. By comparing experiments and theory, we conclude that 1 out of 4  $\text{Ar}^+$  ions creates one di-vacancy and that a 0.03% of di-vacancies produces an increase of three orders of magnitude in the resistance of a 400 nm SWNT length. The theoretical calculations also predict a linear dependence of the localization length with the distance between di-vacancies, in good agreement with the experimental data. The present results are relevant for the performance of nanotube-based sensor devices.